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### [Understanding Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	11519
Number of Logic Elements/Cells	147443
Total RAM Bits	4939776
Number of I/O	296
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	484-BBGA
Supplier Device Package	484-FBGA (23x23)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6slx150t-n3fg484i">https://www.e-xfl.com/product-detail/xilinx/xc6slx150t-n3fg484i</a>

In **Table 9** and **Table 10**, values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

**Table 9: Single-Ended I/O Standard DC Input and Output Levels**

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA	mA
LVTTL	-0.5	0.8	2.0	4.1	0.4	2.4	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS33	-0.5	0.8	2.0	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS25	-0.5	0.7	1.7	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18	-0.5	0.38	0.8	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18 (-1L)	-0.5	0.33	0.71	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS15	-0.5	0.38	0.8	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS15 (-1L)	-0.5	0.33	0.71	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS15_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS12	-0.5	0.38	0.8	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
LVCMOS12 (-1L)	-0.5	0.33	0.71	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
LVCMOS12_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
PCI33_3	-0.5	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.5$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
PCI66_3	-0.5	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.5$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
I2C	-0.5	25% $V_{CCO}$	70% $V_{CCO}$	4.1	20% $V_{CCO}$	-	3	-
SMBUS	-0.5	0.8	2.1	4.1	0.4	-	4	-
SDIO	-0.5	12.5% $V_{CCO}$	75% $V_{CCO}$	4.1	12.5% $V_{CCO}$	75% $V_{CCO}$	0.1	-0.1
MOBILE_DDR	-0.5	20% $V_{CCO}$	80% $V_{CCO}$	4.1	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
HSTL_I	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	8	-8
HSTL_II	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	16	-16
HSTL_III	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	24	-8
HSTL_I_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	11	-11
HSTL_II_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	22	-22
HSTL_III_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	30	-11
SSTL3_I	-0.5	$V_{REF} - 0.2$	$V_{REF} + 0.2$	4.1	$V_{TT} - 0.6$	$V_{TT} + 0.6$	8	-8
SSTL3_II	-0.5	$V_{REF} - 0.2$	$V_{REF} + 0.2$	4.1	$V_{TT} - 0.8$	$V_{TT} + 0.8$	16	-16
SSTL2_I	-0.5	$V_{REF} - 0.15$	$V_{REF} + 0.15$	4.1	$V_{TT} - 0.61$	$V_{TT} + 0.61$	8.1	-8.1
SSTL2_II	-0.5	$V_{REF} - 0.15$	$V_{REF} + 0.15$	4.1	$V_{TT} - 0.81$	$V_{TT} + 0.81$	16.2	-16.2
SSTL18_I	-0.5	$V_{REF} - 0.125$	$V_{REF} + 0.125$	4.1	$V_{TT} - 0.47$	$V_{TT} + 0.47$	6.7	-6.7
SSTL18_II	-0.5	$V_{REF} - 0.125$	$V_{REF} + 0.125$	4.1	$V_{TT} - 0.60$	$V_{TT} + 0.60$	13.4	-13.4
SSTL15_II	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	$V_{TT} - 0.4$	$V_{TT} + 0.4$	13.4	-13.4

#### Notes:

- Tested according to relevant specifications.
- Using drive strengths of 2, 4, 6, 8, 12, 16, or 24 mA.
- Using drive strengths of 2, 4, 6, 8, 12, or 16 mA.
- Using drive strengths of 2, 4, 6, 8, or 12 mA.
- For more information, refer to [UG381: Spartan-6 FPGA SelectIO Resources User Guide](#).

Table 14: GTP Transceiver Current Supply (per Lane)

Symbol	Description	Typ <sup>(1)</sup>	Max	Units
I <sub>MGTAVCC</sub>	GTP transceiver internal analog supply current	40.4	Note 2	mA
I <sub>MGTAVTTX</sub>	GTP transmitter termination supply current	27.4		mA
I <sub>MGTAVTRX</sub>	GTP receiver termination supply current	13.6		mA
I <sub>MGTAVCCPLL</sub>	GTP transmitter and receiver PLL supply current	28.7		mA
R <sub>MGTRREF</sub>	Precision reference resistor for internal calibration termination	50.0 ± 1% tolerance		Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C, with a 2.5 Gb/s line rate, with a shared PLL use mode.
2. Values for currents of other transceiver configurations and conditions can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.

Table 15: GTP Transceiver Quiescent Supply Current (per Lane)<sup>(1)(2)(3)(4)</sup>

Symbol	Description	Typ <sup>(5)</sup>	Max	Units
I <sub>MGTAVCCQ</sub>	Quiescent MGTAVCC supply current	1.7	Note 2	mA
I <sub>MGTAVTTXQ</sub>	Quiescent MGTAVTTX supply current	0.1		mA
I <sub>MGTAVTRXQ</sub>	Quiescent MGTAVTRX supply current	1.2		mA
I <sub>MGTAVCCPLQ</sub>	Quiescent MGTAVCCPLL supply current	1.0		mA

**Notes:**

1. Device powered and unconfigured.
2. Currents for conditions other than values specified in this table can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.
3. GTP transceiver quiescent supply current for an entire device can be calculated by multiplying the values in this table by the number of available GTP transceivers.
4. Does not include power-up MGTAVTTRCAL supply current during device configuration.
5. Typical values are specified at nominal voltage, 25°C.

Table 17: GTP Transceiver Clock DC Input Level Specification

Symbol	DC Parameter	Min	Typ	Max	Units
$V_{IDIFF}$	Differential peak-to-peak input voltage	200	800	2000	mV
$R_{IN}$	Differential input resistance	80	100	120	$\Omega$
$C_{EXT}$	Required external AC coupling capacitor	—	100	—	nF

## GTP Transceiver Switching Characteristics

Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further information.

Table 18: GTP Transceiver Performance

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
$F_{GTPMAX}$	Maximum GTP transceiver data rate	3.2	3.2	2.7	N/A	Gb/s
$F_{GTPRANGE1}$	GTP transceiver data rate range when $PLL\_TXDIVSEL\_OUT = 1$	1.88 to 3.2	1.88 to 3.2	1.88 to 2.7	N/A	Gb/s
$F_{GTPRANGE2}$	GTP transceiver data rate range when $PLL\_TXDIVSEL\_OUT = 2$	0.94 to 1.62	0.94 to 1.62	0.94 to 1.62	N/A	Gb/s
$F_{GTPRANGE3}$	GTP transceiver data rate range when $PLL\_TXDIVSEL\_OUT = 4$	0.6 to 0.81	0.6 to 0.81	0.6 to 0.81	N/A	Gb/s
$F_{GPLLMAX}$	Maximum PLL frequency	1.62	1.62	1.62	N/A	GHz
$F_{GPLLMIN}$	Minimum PLL frequency	0.94	0.94	0.94	N/A	GHz

Table 19: GTP Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
$F_{GTPDRPCLK}$	GTP transceiver DCLK (DRP clock) maximum frequency	125	125	100	N/A	MHz

Table 20: GTP Transceiver Reference Clock Switching Characteristics

Symbol	Description	Conditions	All LXT Speed Grades			Units
			Min	Typ	Max	
$F_{GCLK}$	Reference clock frequency range		60	—	160	MHz
$T_{RCLK}$	Reference clock rise time	20% – 80%	—	200	—	ps
$T_{FCLK}$	Reference clock fall time	80% – 20%	—	200	—	ps
$T_{DCREF}$	Reference clock duty cycle	Transceiver PLL only	45	50	55	%
$T_{LOCK}$	Clock recovery frequency acquisition time	Initial PLL lock	—	—	1	ms
$T_{PHASE}$	Clock recovery phase acquisition time	Lock to data after PLL has locked to the reference clock	—	—	200	$\mu$ s

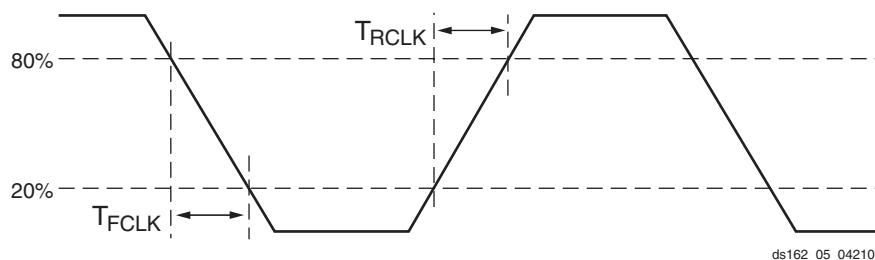


Figure 3: Reference Clock Timing Parameters

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Spartan-6 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [Switching Characteristics, page 19](#).

**Table 25: Interface Performances**

<b>Description</b>	<b>I/O Resource</b>	<b>Clock Buffer</b>	<b>Data Width</b>	<b>Speed Grade</b>				<b>Units</b>		
				<b>-3</b>	<b>-3N</b>	<b>-2</b>	<b>-1L</b>			
<b>Networking Applications<sup>(1)</sup></b>										
SDR LVDS transmitter or receiver	IOB SDR register	BUFG	—	400	400	375	250	Mb/s		
DDR LVDS transmitter or receiver	ODDR2/IDDR2 register	2 BUFGs	—	800	800	750	500	Mb/s		
SDR LVDS transmitter	OSERDES2	BUFPLL	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
DDR LVDS transmitter	OSERDES2	2 BUFIO2s	2	500	500	500	250	Mb/s		
			3	750	750	750	375	Mb/s		
			4-8	1080	1050	950	500	Mb/s		
SDR LVDS receiver	ISERDES2 in RETIMED mode	BUFPLL	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
DDR LVDS receiver	ISERDES2 in RETIMED mode	2 BUFIO2s	2	500	500	500	—	Mb/s		
			3	750	750	750	—	Mb/s		
			4-8	1080	1050	950	—	Mb/s		
<b>Memory Interfaces (Implemented using the Spartan-6 FPGA Memory Controller Block)<sup>(2)</sup></b>										
<b>Standard Performance (Standard V<sub>CCINT</sub>)</b>										
DDR				400	<a href="#">Note 4</a>	400	350	Mb/s		
DDR2				667	<a href="#">Note 4</a>	625	400	Mb/s		
DDR3				800	<a href="#">Note 4</a>	667	—	Mb/s		
LPDDR (Mobile_DDR)				400	<a href="#">Note 4</a>	400	350	Mb/s		
<b>Extended Performance (Requires Extended Performance V<sub>CCINT</sub>)<sup>(3)</sup></b>										
DDR2				800	<a href="#">Note 4</a>	667	—	Mb/s		

**Notes:**

- Refer to [XAPP1064](#), *Source-Synchronous Serialization and Deserialization (up to 1050 Mb/s)* and [UG381](#), *Spartan-6 FPGA SelectIO Resources User Guide*.
- Refer to [UG388](#), *Spartan-6 FPGA Memory Controller User Guide*.
- Extended Memory Controller block performance for DDR2 can be achieved using the extended performance V<sub>CCINT</sub> range from [Table 2](#).
- The LX4 device, all devices in the TQG144 and CPG196 packages, and the -3N speed grade do not support a Memory Controller Block.

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVCMOS18, Slow, 24 mA	1.18	1.30	1.43	2.04	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	
LVCMOS18, Fast, 2 mA	1.18	1.30	1.43	2.04	3.59	3.73	3.93	4.53	3.59	3.73	3.93	4.53	ns	
LVCMOS18, Fast, 4 mA	1.18	1.30	1.43	2.04	2.39	2.53	2.73	3.35	2.39	2.53	2.73	3.35	ns	
LVCMOS18, Fast, 6 mA	1.18	1.30	1.43	2.04	1.88	2.02	2.22	2.84	1.88	2.02	2.22	2.84	ns	
LVCMOS18, Fast, 8 mA	1.18	1.30	1.43	2.04	1.81	1.95	2.15	2.77	1.81	1.95	2.15	2.77	ns	
LVCMOS18, Fast, 12 mA	1.18	1.30	1.43	2.04	1.71	1.85	2.05	2.67	1.71	1.85	2.05	2.67	ns	
LVCMOS18, Fast, 16 mA	1.18	1.30	1.43	2.04	1.71	1.85	2.05	2.67	1.71	1.85	2.05	2.67	ns	
LVCMOS18, Fast, 24 mA	1.18	1.30	1.43	2.04	1.71	1.85	2.05	2.67	1.71	1.85	2.05	2.67	ns	
LVCMOS18_JEDEC, QUIETIO, 2 mA	0.94	1.06	1.19	1.41	5.91	6.05	6.25	6.79	5.91	6.05	6.25	6.79	ns	
LVCMOS18_JEDEC, QUIETIO, 4 mA	0.94	1.06	1.19	1.41	4.75	4.89	5.09	5.64	4.75	4.89	5.09	5.64	ns	
LVCMOS18_JEDEC, QUIETIO, 6 mA	0.94	1.06	1.19	1.41	4.04	4.18	4.38	4.96	4.04	4.18	4.38	4.96	ns	
LVCMOS18_JEDEC, QUIETIO, 8 mA	0.94	1.06	1.19	1.41	3.71	3.85	4.05	4.62	3.71	3.85	4.05	4.62	ns	
LVCMOS18_JEDEC, QUIETIO, 12 mA	0.94	1.06	1.19	1.41	3.35	3.49	3.69	4.28	3.35	3.49	3.69	4.28	ns	
LVCMOS18_JEDEC, QUIETIO, 16 mA	0.94	1.06	1.19	1.41	3.20	3.34	3.54	4.13	3.20	3.34	3.54	4.13	ns	
LVCMOS18_JEDEC, QUIETIO, 24 mA	0.94	1.06	1.19	1.41	2.96	3.10	3.30	3.98	2.96	3.10	3.30	3.98	ns	
LVCMOS18_JEDEC, Slow, 2 mA	0.94	1.06	1.19	1.41	4.59	4.73	4.93	5.54	4.59	4.73	4.93	5.54	ns	
LVCMOS18_JEDEC, Slow, 4 mA	0.94	1.06	1.19	1.41	3.69	3.83	4.03	4.60	3.69	3.83	4.03	4.60	ns	
LVCMOS18_JEDEC, Slow, 6 mA	0.94	1.06	1.19	1.41	3.00	3.14	3.34	3.94	3.00	3.14	3.34	3.94	ns	
LVCMOS18_JEDEC, Slow, 8 mA	0.94	1.06	1.19	1.41	2.19	2.33	2.53	3.18	2.19	2.33	2.53	3.18	ns	
LVCMOS18_JEDEC, Slow, 12 mA	0.94	1.06	1.19	1.41	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	
LVCMOS18_JEDEC, Slow, 16 mA	0.94	1.06	1.19	1.41	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	
LVCMOS18_JEDEC, Slow, 24 mA	0.94	1.06	1.19	1.41	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	
LVCMOS18_JEDEC, Fast, 2 mA	0.94	1.06	1.19	1.41	3.57	3.71	3.91	4.52	3.57	3.71	3.91	4.52	ns	
LVCMOS18_JEDEC, Fast, 4 mA	0.94	1.06	1.19	1.41	2.39	2.53	2.73	3.35	2.39	2.53	2.73	3.35	ns	
LVCMOS18_JEDEC, Fast, 6 mA	0.94	1.06	1.19	1.41	1.88	2.02	2.22	2.84	1.88	2.02	2.22	2.84	ns	
LVCMOS18_JEDEC, Fast, 8 mA	0.94	1.06	1.19	1.41	1.80	1.94	2.14	2.76	1.80	1.94	2.14	2.76	ns	
LVCMOS18_JEDEC, Fast, 12 mA	0.94	1.06	1.19	1.41	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
LVCMOS18_JEDEC, Fast, 16 mA	0.94	1.06	1.19	1.41	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
LVCMOS18_JEDEC, Fast, 24 mA	0.94	1.06	1.19	1.41	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
LVCMOS15, QUIETIO, 2 mA	0.98	1.10	1.23	1.79	5.47	5.61	5.81	6.38	5.47	5.61	5.81	6.38	ns	
LVCMOS15, QUIETIO, 4 mA	0.98	1.10	1.23	1.79	4.61	4.75	4.95	5.51	4.61	4.75	4.95	5.51	ns	
LVCMOS15, QUIETIO, 6 mA	0.98	1.10	1.23	1.79	4.07	4.21	4.41	4.97	4.07	4.21	4.41	4.97	ns	
LVCMOS15, QUIETIO, 8 mA	0.98	1.10	1.23	1.79	3.91	4.05	4.25	4.81	3.91	4.05	4.25	4.81	ns	
LVCMOS15, QUIETIO, 12 mA	0.98	1.10	1.23	1.79	3.53	3.67	3.87	4.51	3.53	3.67	3.87	4.51	ns	
LVCMOS15, QUIETIO, 16 mA	0.98	1.10	1.23	1.79	3.32	3.46	3.66	4.31	3.32	3.46	3.66	4.31	ns	
LVCMOS15, Slow, 2 mA	0.98	1.10	1.23	1.79	4.18	4.32	4.52	5.11	4.18	4.32	4.52	5.11	ns	
LVCMOS15, Slow, 4 mA	0.98	1.10	1.23	1.79	3.42	3.56	3.76	4.34	3.42	3.56	3.76	4.34	ns	
LVCMOS15, Slow, 6 mA	0.98	1.10	1.23	1.79	2.29	2.43	2.63	3.24	2.29	2.43	2.63	3.24	ns	

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>LOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVCMOS15, Slow, 8 mA	0.98	1.10	1.23	1.79	2.30	2.44	2.64	3.25	2.30	2.44	2.64	3.25	ns	
LVCMOS15, Slow, 12 mA	0.98	1.10	1.23	1.79	2.03	2.17	2.37	2.99	2.03	2.17	2.37	2.99	ns	
LVCMOS15, Slow, 16 mA	0.98	1.10	1.23	1.79	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15, Fast, 2 mA	0.98	1.10	1.23	1.79	3.29	3.43	3.63	4.24	3.29	3.43	3.63	4.24	ns	
LVCMOS15, Fast, 4 mA	0.98	1.10	1.23	1.79	2.27	2.41	2.61	3.22	2.27	2.41	2.61	3.22	ns	
LVCMOS15, Fast, 6 mA	0.98	1.10	1.23	1.79	1.78	1.92	2.12	2.74	1.78	1.92	2.12	2.74	ns	
LVCMOS15, Fast, 8 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.69	1.73	1.87	2.07	2.69	ns	
LVCMOS15, Fast, 12 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.64	1.73	1.87	2.07	2.64	ns	
LVCMOS15, Fast, 16 mA	0.98	1.10	1.23	1.79	1.73	1.87	2.07	2.64	1.73	1.87	2.07	2.64	ns	
LVCMOS15_JEDEC, QUIETIO, 2 mA	1.03	1.15	1.28	1.49	5.49	5.63	5.83	6.37	5.49	5.63	5.83	6.37	ns	
LVCMOS15_JEDEC, QUIETIO, 4 mA	1.03	1.15	1.28	1.49	4.61	4.75	4.95	5.51	4.61	4.75	4.95	5.51	ns	
LVCMOS15_JEDEC, QUIETIO, 6 mA	1.03	1.15	1.28	1.49	4.07	4.21	4.41	4.97	4.07	4.21	4.41	4.97	ns	
LVCMOS15_JEDEC, QUIETIO, 8 mA	1.03	1.15	1.28	1.49	3.92	4.06	4.26	4.81	3.92	4.06	4.26	4.81	ns	
LVCMOS15_JEDEC, QUIETIO, 12 mA	1.03	1.15	1.28	1.49	3.54	3.68	3.88	4.51	3.54	3.68	3.88	4.51	ns	
LVCMOS15_JEDEC, QUIETIO, 16 mA	1.03	1.15	1.28	1.49	3.33	3.47	3.67	4.31	3.33	3.47	3.67	4.31	ns	
LVCMOS15_JEDEC, Slow, 2 mA	1.03	1.15	1.28	1.49	4.18	4.32	4.52	5.13	4.18	4.32	4.52	5.13	ns	
LVCMOS15_JEDEC, Slow, 4 mA	1.03	1.15	1.28	1.49	3.42	3.56	3.76	4.35	3.42	3.56	3.76	4.35	ns	
LVCMOS15_JEDEC, Slow, 6 mA	1.03	1.15	1.28	1.49	2.29	2.43	2.63	3.25	2.29	2.43	2.63	3.25	ns	
LVCMOS15_JEDEC, Slow, 8 mA	1.03	1.15	1.28	1.49	2.30	2.44	2.64	3.26	2.30	2.44	2.64	3.26	ns	
LVCMOS15_JEDEC, Slow, 12 mA	1.03	1.15	1.28	1.49	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15_JEDEC, Slow, 16 mA	1.03	1.15	1.28	1.49	2.01	2.15	2.35	2.97	2.01	2.15	2.35	2.97	ns	
LVCMOS15_JEDEC, Fast, 2 mA	1.03	1.15	1.28	1.49	3.28	3.42	3.62	4.22	3.28	3.42	3.62	4.22	ns	
LVCMOS15_JEDEC, Fast, 4 mA	1.03	1.15	1.28	1.49	2.27	2.41	2.61	3.23	2.27	2.41	2.61	3.23	ns	
LVCMOS15_JEDEC, Fast, 6 mA	1.03	1.15	1.28	1.49	1.78	1.92	2.12	2.74	1.78	1.92	2.12	2.74	ns	
LVCMOS15_JEDEC, Fast, 8 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.69	1.73	1.87	2.07	2.69	ns	
LVCMOS15_JEDEC, Fast, 12 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.63	1.73	1.87	2.07	2.63	ns	
LVCMOS15_JEDEC, Fast, 16 mA	1.03	1.15	1.28	1.49	1.73	1.87	2.07	2.63	1.73	1.87	2.07	2.63	ns	
LVCMOS12, QUIETIO, 2 mA	0.91	1.03	1.16	1.51	6.40	6.54	6.74	7.30	6.40	6.54	6.74	7.30	ns	
LVCMOS12, QUIETIO, 4 mA	0.91	1.03	1.16	1.51	4.98	5.12	5.32	5.90	4.98	5.12	5.32	5.90	ns	
LVCMOS12, QUIETIO, 6 mA	0.91	1.03	1.16	1.51	4.65	4.79	4.99	5.55	4.65	4.79	4.99	5.55	ns	
LVCMOS12, QUIETIO, 8 mA	0.91	1.03	1.16	1.51	4.23	4.37	4.57	5.21	4.23	4.37	4.57	5.21	ns	
LVCMOS12, QUIETIO, 12 mA	0.91	1.03	1.16	1.51	3.98	4.12	4.32	4.94	3.98	4.12	4.32	4.94	ns	
LVCMOS12, Slow, 2 mA	0.91	1.03	1.16	1.51	4.98	5.12	5.32	5.91	4.98	5.12	5.32	5.91	ns	
LVCMOS12, Slow, 4 mA	0.91	1.03	1.16	1.51	2.84	2.98	3.18	3.81	2.84	2.98	3.18	3.81	ns	
LVCMOS12, Slow, 6 mA	0.91	1.03	1.16	1.51	2.77	2.91	3.11	3.72	2.77	2.91	3.11	3.72	ns	
LVCMOS12, Slow, 8 mA	0.91	1.03	1.16	1.51	2.34	2.48	2.68	3.31	2.34	2.48	2.68	3.31	ns	
LVCMOS12, Slow, 12 mA	0.91	1.03	1.16	1.51	2.08	2.22	2.42	3.06	2.08	2.22	2.42	3.06	ns	

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup>

I/O Standard	T <sub>IOP1</sub>		T <sub>IOP0</sub>		T <sub>IOTP</sub>		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
LVDS_33	1.24	1.42	1.69	1.89	3000	3000	ns	
LVDS_25	1.08	1.26	1.79	1.99	3000	3000	ns	
BLVDS_25	1.09	1.27	1.86	2.06	1.86	2.06	ns	
MINI_LVDS_33	1.25	1.43	1.71	1.91	3000	3000	ns	
MINI_LVDS_25	1.08	1.26	1.79	1.99	3000	3000	ns	
LVPECL_33	1.25	1.43	N/A	N/A	N/A	N/A	ns	
LVPECL_25	1.09	1.27	N/A	N/A	N/A	N/A	ns	
RSDS_33 (point to point)	1.24	1.42	1.71	1.91	3000	3000	ns	
RSDS_25 (point to point)	1.08	1.26	1.79	1.99	3000	3000	ns	
TMDS_33	1.29	1.47	1.68	1.88	3000	3000	ns	
PPDS_33	1.25	1.43	1.71	1.91	3000	3000	ns	
PPDS_25	1.08	1.26	1.82	2.02	3000	3000	ns	
PCI33_3	1.14	1.32	3.81	4.01	3.81	4.01	ns	
PCI66_3	1.14	1.32	3.81	4.01	3.81	4.01	ns	
DISPLAY_PORT	1.09	1.27	3.29	3.49	3.29	3.49	ns	
I2C	1.40	1.58	11.70	11.90	11.70	11.90	ns	
SMBUS	1.40	1.58	11.70	11.90	11.70	11.90	ns	
SDIO	1.43	1.61	2.78	2.98	2.78	2.98	ns	
MOBILE_DDR	1.01	1.19	2.50	2.70	2.50	2.70	ns	
HSTL_I	1.01	1.19	1.80	2.00	1.80	2.00	ns	
HSTL_II	1.01	1.19	1.86	2.06	1.86	2.06	ns	
HSTL_III	1.07	1.25	1.81	2.01	1.81	2.01	ns	
HSTL_I_18	1.05	1.23	1.91	2.11	1.91	2.11	ns	
HSTL_II_18	1.05	1.23	1.99	2.19	1.99	2.19	ns	
HSTL_III_18	1.13	1.31	1.93	2.13	1.93	2.13	ns	
SSTL3_I	1.65	1.83	1.97	2.17	1.97	2.17	ns	
SSTL3_II	1.65	1.83	2.15	2.35	2.15	2.35	ns	
SSTL2_I	1.37	1.55	1.91	2.11	1.91	2.11	ns	
SSTL2_II	1.37	1.55	2.00	2.20	2.00	2.20	ns	
SSTL18_I	0.99	1.17	1.77	1.97	1.77	1.97	ns	
SSTL18_II	1.00	1.18	1.80	2.00	1.80	2.00	ns	
SSTL15_II	1.00	1.18	1.81	2.01	1.81	2.01	ns	
DIFF_HSTL_I	1.01	1.19	1.91	2.11	1.91	2.11	ns	
DIFF_HSTL_II	1.00	1.18	1.86	2.06	1.86	2.06	ns	
DIFF_HSTL_III	1.00	1.18	1.83	2.03	1.83	2.03	ns	
DIFF_HSTL_I_18	1.04	1.22	1.93	2.13	1.93	2.13	ns	
DIFF_HSTL_II_18	1.04	1.22	1.83	2.03	1.83	2.03	ns	
DIFF_HSTL_III_18	1.04	1.22	1.83	2.03	1.83	2.03	ns	

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup> (Cont'd)

I/O Standard	T <sub>IOP1</sub>		T <sub>IOOP</sub>		T <sub>IOTP</sub>		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
DIFF_SSTL3_I	1.26	1.44	1.95	2.15	1.95	2.15	ns	
DIFF_SSTL3_II	1.26	1.44	1.94	2.14	1.94	2.14	ns	
DIFF_SSTL2_I	1.09	1.27	1.94	2.14	1.94	2.14	ns	
DIFF_SSTL2_II	1.09	1.27	1.90	2.10	1.90	2.10	ns	
DIFF_SSTL18_I	1.04	1.22	1.86	2.06	1.86	2.06	ns	
DIFF_SSTL18_II	1.05	1.23	1.82	2.02	1.82	2.02	ns	
DIFF_SSTL15_II	1.01	1.19	1.81	2.01	1.81	2.01	ns	
DIFF_MOBILE_DDR	1.04	1.22	1.89	2.09	1.89	2.09	ns	
LVTTL, QUIETIO, 2 mA	1.42	1.60	5.64	5.84	5.64	5.84	ns	
LVTTL, QUIETIO, 4 mA	1.42	1.60	4.46	4.66	4.46	4.66	ns	
LVTTL, QUIETIO, 6 mA	1.42	1.60	3.92	4.12	3.92	4.12	ns	
LVTTL, QUIETIO, 8 mA	1.42	1.60	3.37	3.57	3.37	3.57	ns	
LVTTL, QUIETIO, 12 mA	1.42	1.60	3.42	3.62	3.42	3.62	ns	
LVTTL, QUIETIO, 16 mA	1.42	1.60	3.09	3.29	3.09	3.29	ns	
LVTTL, QUIETIO, 24 mA	1.42	1.60	2.83	3.03	2.83	3.03	ns	
LVTTL, Slow, 2 mA	1.42	1.60	4.58	4.78	4.58	4.78	ns	
LVTTL, Slow, 4 mA	1.42	1.60	3.38	3.58	3.38	3.58	ns	
LVTTL, Slow, 6 mA	1.42	1.60	2.95	3.15	2.95	3.15	ns	
LVTTL, Slow, 8 mA	1.42	1.60	2.73	2.93	2.73	2.93	ns	
LVTTL, Slow, 12 mA	1.42	1.60	2.72	2.92	2.72	2.92	ns	
LVTTL, Slow, 16 mA	1.42	1.60	2.53	2.73	2.53	2.73	ns	
LVTTL, Slow, 24 mA	1.42	1.60	2.42	2.62	2.42	2.62	ns	
LVTTL, Fast, 2 mA	1.42	1.60	4.04	4.24	4.04	4.24	ns	
LVTTL, Fast, 4 mA	1.42	1.60	2.66	2.86	2.66	2.86	ns	
LVTTL, Fast, 6 mA	1.42	1.60	2.58	2.78	2.58	2.78	ns	
LVTTL, Fast, 8 mA	1.42	1.60	2.46	2.66	2.46	2.66	ns	
LVTTL, Fast, 12 mA	1.42	1.60	1.97	2.17	1.97	2.17	ns	
LVTTL, Fast, 16 mA	1.42	1.60	1.97	2.17	1.97	2.17	ns	
LVTTL, Fast, 24 mA	1.42	1.60	1.97	2.17	1.97	2.17	ns	
LVCMOS33, QUIETIO, 2 mA	1.41	1.59	5.65	5.85	5.65	5.85	ns	
LVCMOS33, QUIETIO, 4 mA	1.41	1.59	4.20	4.40	4.20	4.40	ns	
LVCMOS33, QUIETIO, 6 mA	1.41	1.59	3.65	3.85	3.65	3.85	ns	
LVCMOS33, QUIETIO, 8 mA	1.41	1.59	3.51	3.71	3.51	3.71	ns	
LVCMOS33, QUIETIO, 12 mA	1.41	1.59	3.09	3.29	3.09	3.29	ns	
LVCMOS33, QUIETIO, 16 mA	1.41	1.59	2.91	3.11	2.91	3.11	ns	
LVCMOS33, QUIETIO, 24 mA	1.41	1.59	2.73	2.93	2.73	2.93	ns	
LVCMOS33, Slow, 2 mA	1.41	1.59	4.59	4.79	4.59	4.79	ns	
LVCMOS33, Slow, 4 mA	1.41	1.59	3.14	3.34	3.14	3.34	ns	

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup> (Cont'd)

I/O Standard	T <sub>IOP1</sub>		T <sub>IOOP</sub>		T <sub>IOTP</sub>		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
LVCMOS18, QUIETIO, 16 mA	1.25	1.43	3.34	3.54	3.34	3.54	ns	
LVCMOS18, QUIETIO, 24 mA	1.25	1.43	3.18	3.38	3.18	3.38	ns	
LVCMOS18, Slow, 2 mA	1.25	1.43	4.79	4.99	4.79	4.99	ns	
LVCMOS18, Slow, 4 mA	1.25	1.43	3.84	4.04	3.84	4.04	ns	
LVCMOS18, Slow, 6 mA	1.25	1.43	3.17	3.37	3.17	3.37	ns	
LVCMOS18, Slow, 8 mA	1.25	1.43	2.37	2.57	2.37	2.57	ns	
LVCMOS18, Slow, 12 mA	1.25	1.43	2.13	2.33	2.13	2.33	ns	
LVCMOS18, Slow, 16 mA	1.25	1.43	2.13	2.33	2.13	2.33	ns	
LVCMOS18, Slow, 24 mA	1.25	1.43	2.13	2.33	2.13	2.33	ns	
LVCMOS18, Fast, 2 mA	1.25	1.43	3.78	3.98	3.78	3.98	ns	
LVCMOS18, Fast, 4 mA	1.25	1.43	2.54	2.74	2.54	2.74	ns	
LVCMOS18, Fast, 6 mA	1.25	1.43	2.02	2.22	2.02	2.22	ns	
LVCMOS18, Fast, 8 mA	1.25	1.43	1.95	2.15	1.95	2.15	ns	
LVCMOS18, Fast, 12 mA	1.25	1.43	1.85	2.05	1.85	2.05	ns	
LVCMOS18, Fast, 16 mA	1.25	1.43	1.85	2.05	1.85	2.05	ns	
LVCMOS18, Fast, 24 mA	1.25	1.43	1.85	2.05	1.85	2.05	ns	
LVCMOS18_JEDEC, QUIETIO, 2 mA	1.01	1.19	6.09	6.29	6.09	6.29	ns	
LVCMOS18_JEDEC, QUIETIO, 4 mA	1.01	1.19	4.89	5.09	4.89	5.09	ns	
LVCMOS18_JEDEC, QUIETIO, 6 mA	1.01	1.19	4.20	4.40	4.20	4.40	ns	
LVCMOS18_JEDEC, QUIETIO, 8 mA	1.01	1.19	3.87	4.07	3.87	4.07	ns	
LVCMOS18_JEDEC, QUIETIO, 12 mA	1.01	1.19	3.49	3.69	3.49	3.69	ns	
LVCMOS18_JEDEC, QUIETIO, 16 mA	1.01	1.19	3.34	3.54	3.34	3.54	ns	
LVCMOS18_JEDEC, QUIETIO, 24 mA	1.01	1.19	3.17	3.37	3.17	3.37	ns	
LVCMOS18_JEDEC, Slow, 2 mA	1.01	1.19	4.79	4.99	4.79	4.99	ns	
LVCMOS18_JEDEC, Slow, 4 mA	1.01	1.19	3.84	4.04	3.84	4.04	ns	
LVCMOS18_JEDEC, Slow, 6 mA	1.01	1.19	3.18	3.38	3.18	3.38	ns	
LVCMOS18_JEDEC, Slow, 8 mA	1.01	1.19	2.37	2.57	2.37	2.57	ns	
LVCMOS18_JEDEC, Slow, 12 mA	1.01	1.19	2.13	2.33	2.13	2.33	ns	
LVCMOS18_JEDEC, Slow, 16 mA	1.01	1.19	2.13	2.33	2.13	2.33	ns	
LVCMOS18_JEDEC, Slow, 24 mA	1.01	1.19	2.13	2.33	2.13	2.33	ns	
LVCMOS18_JEDEC, Fast, 2 mA	1.01	1.19	3.75	3.95	3.75	3.95	ns	
LVCMOS18_JEDEC, Fast, 4 mA	1.01	1.19	2.54	2.74	2.54	2.74	ns	
LVCMOS18_JEDEC, Fast, 6 mA	1.01	1.19	2.02	2.22	2.02	2.22	ns	
LVCMOS18_JEDEC, Fast, 8 mA	1.01	1.19	1.94	2.14	1.94	2.14	ns	
LVCMOS18_JEDEC, Fast, 12 mA	1.01	1.19	1.86	2.06	1.86	2.06	ns	
LVCMOS18_JEDEC, Fast, 16 mA	1.01	1.19	1.86	2.06	1.86	2.06	ns	
LVCMOS18_JEDEC, Fast, 24 mA	1.01	1.19	1.86	2.06	1.86	2.06	ns	

## I/O Standard Measurement Methodology

### Input Delay Measurements

**Table 31** shows the test setup parameters used for measuring input delay.

**Table 31: Input Delay Measurement Methodology**

Description	I/O Standard Attribute	$V_L^{(1)}$	$V_H^{(1)}$	$V_{MEAS}^{(3)(4)}$	$V_{REF}^{(2)(4)}$
LVTTL (Low-Voltage Transistor-Transistor Logic)	LVTTL	0	3.0	1.4	–
LVCMOS (Low-Voltage CMOS), 3.3V	LVCMOS33	0	3.3	1.65	–
LVCMOS, 2.5V	LVCMOS25	0	2.5	1.25	–
LVCMOS, 1.8V	LVCMOS18	0	1.8	0.9	–
LVCMOS, 1.5V	LVCMOS15	0	1.5	0.75	–
LVCMOS, 1.2V	LVCMOS12	0	1.2	0.6	–
PCI (Peripheral Component Interface), 33 MHz and 66 MHz, 3.3V	PCI33_3, PCI66_3	Per PCI Specification			–
HSTL (High-Speed Transceiver Logic), Class I & II	HSTL_I, HSTL_II	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.75
HSTL, Class III	HSTL_III	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.90
HSTL, Class I & II, 1.8V	HSTL_I_18, HSTL_II_18	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.90
HSTL, Class III 1.8V	HSTL_III_18	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	1.1
SSTL (Stub Terminated Transceiver Logic), Class I & II, 3.3V	SSTL3_I, SSTL3_II	$V_{REF} - 0.75$	$V_{REF} + 0.75$	$V_{REF}$	1.5
SSTL, Class I & II, 2.5V	SSTL2_I, SSTL2_II	$V_{REF} - 0.75$	$V_{REF} + 0.75$	$V_{REF}$	1.25
SSTL, Class I & II, 1.8V	SSTL18_I, SSTL18_II	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.90
SSTL, Class II, 1.5V	SSTL15_II	$V_{REF} - 0.2$	$V_{REF} + 0.2$	$V_{REF}$	0.75
LVDS (Low-Voltage Differential Signaling), 2.5V & 3.3V	LVDS_25, LVDS_33	1.25 – 0.125	1.25 + 0.125	0 <sup>(5)</sup>	–
LVPECL (Low-Voltage Positive Emitter-Coupled Logic), 2.5V & 3.3V	LVPECL_25, LVPECL_33	1.2 – 0.3	1.2 + 0.3	0 <sup>(5)</sup>	–
BLVDS (Bus LVDS), 2.5V	BLVDS_25	1.3 – 0.125	1.3 + 0.125	0 <sup>(5)</sup>	–
Mini-LVDS, 2.5V & 3.3V	MINI_LVDS_25, MINI_LVDS_33	1.2 – 0.125	1.2 + 0.125	0 <sup>(5)</sup>	–
RSDS (Reduced Swing Differential Signaling), 2.5V & 3.3V	RSDS_25, RSDS_33	1.2 – 0.1	1.2 + 0.1	0 <sup>(5)</sup>	–
TMDS (Transition Minimized Differential Signaling), 3.3V	TMDS_33	3.0 – 0.1	3.0 + 0.1	0 <sup>(5)</sup>	–
PPDS (Point-to-Point Differential Signaling), 2.5V & 3.3V	PPDS_25, PPDS_33	1.25 – 0.1	1.25 + 0.1	0 <sup>(5)</sup>	–

**Notes:**

1. Input waveform switches between  $V_L$  and  $V_H$ .
2. Measurements are made at typical, minimum, and maximum  $V_{REF}$  values. Reported delays reflect worst case of these measurements.  $V_{REF}$  values listed are typical.
3. Input voltage level from which measurement starts.
4. This is an input voltage reference that bears no relation to the  $V_{REF}$  /  $V_{MEAS}$  parameters found in IBIS models and/or noted in [Figure 4](#).
5. The value given is the differential input voltage.

## Input/Output Logic Switching Characteristics

Table 35: ILOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ICE0CK</sub> /T <sub>ICKCE0</sub>	CE0 pin Setup/Hold with respect to CLK	0.56/ -0.30	0.56/ -0.25	0.79/ -0.22	1.21/ -0.52	ns
T <sub>ISRCK</sub> /T <sub>ICKSR</sub>	SR pin Setup/Hold with respect to CLK	0.74/ -0.23	0.74/ -0.22	0.98/ -0.20	1.31/ -0.45	ns
T <sub>IDOCK</sub> /T <sub>IOCKD</sub>	D pin Setup/Hold with respect to CLK without Delay	1.19/ -0.83	1.36/ -0.83	1.73/ -0.83	2.18/ -1.77	ns
T <sub>IDOCKD</sub> /T <sub>IOCKDD</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY2)	0.31/ 0.00	0.47/ 0.00	0.54/ 0.00	0.63/ -0.39	ns
<b>Combinatorial</b>						
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.95	1.28	1.53	2.25	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IODELAY2)	0.23	0.39	0.44	0.74	ns
<b>Sequential Delays</b>						
T <sub>IDLO</sub>	D pin to Q pin using flip-flop as a latch without Delay	1.56	1.86	2.39	3.49	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IODELAY2)	0.68	0.97	1.20	1.94	ns
T <sub>ICKQ</sub>	CLK to Q outputs for XC devices	1.03	1.24	1.43	2.11	ns
	CLK to Q outputs for XA and XQ devices	1.38	N/A	1.78	2.11	ns
T <sub>RQ_ILOGIC2</sub>	SR pin to Q outputs	1.81	1.81	2.50	3.05	ns

Table 36: OLOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ODCK</sub> /T <sub>OCKD</sub>	D1/D2 pins Setup/Hold with respect to CLK	0.81/ -0.05	0.86/ -0.05	1.18/ 0.00	1.73/ -0.27	ns
T <sub>OOC ECK</sub> /T <sub>OCKOCE</sub>	OCE pin Setup/Hold with respect to CLK	0.75/ -0.10	0.75/ -0.10	1.01/ -0.05	1.66/ -0.23	ns
T <sub>OSRCK</sub> /T <sub>OCKSR</sub>	SR pin Setup/Hold with respect to CLK	0.70/ -0.28	0.79/ -0.28	1.03/ -0.23	1.39/ -0.47	ns
T <sub>OTCK</sub> /T <sub>OCKT</sub>	T1/T2 pins Setup/Hold with respect to CLK	0.24/ -0.08	0.56/ -0.06	0.83/ -0.01	0.99/ -0.19	ns
T <sub>OTCECK</sub> /T <sub>OCKTCE</sub>	TCE pin Setup/Hold with respect to CLK	0.58/ -0.06	0.72/ -0.06	1.18/ -0.01	1.51/ -0.13	ns
<b>Sequential Delays</b>						
T <sub>OCKQ</sub>	CLK to OQ/TQ out for XC devices	0.48	0.51	0.74	0.74	ns
	CLK to OQ/TQ out for XA and XQ devices	0.85	N/A	1.16	0.74	ns
T <sub>RQ_OLOGIC2</sub>	SR pin to OQ/TQ out	1.81	1.81	2.50	3.05	ns

## Input Serializer/Deserializer Switching Characteristics

Table 37: ISERDES2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold for Control Lines</b>						
T <sub>ISCKC_BITSLIP</sub> / T <sub>ISCKC_BITSLIP</sub>	BITSLIP pin Setup/Hold with respect to CLKDIV	0.16/ -0.09	0.20/ -0.09	0.31/ -0.09	0.34/ -0.14	ns
T <sub>ISCKC_CE</sub> / T <sub>ISCKC_CE</sub>	CE pin Setup/Hold with respect to CLK	0.71/ -0.47	0.71/ -0.42	0.97/ -0.42	1.39/ -0.71	ns
<b>Setup/Hold for Data Lines</b>						
T <sub>ISDCK_D</sub> / T <sub>ISCKD_D</sub>	D pin Setup/Hold with respect to CLK	0.24/ -0.15	0.25/ -0.05	0.29/ -0.05	0.09/ -0.05	ns
T <sub>ISDCK_DDLY</sub> / T <sub>ISCKD_DDLY</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY2)	-0.25/ 0.30	-0.25/ 0.42	-0.25/ 0.56	-0.54/ 0.67	ns
T <sub>ISDCK_D_DDR</sub> / T <sub>ISCKD_D_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode	-0.03/ 0.04	-0.03/ 0.16	-0.03/ 0.18	-0.05/ 0.12	ns
T <sub>ISDCK_DDLY_DDR</sub> / T <sub>ISCKD_DDLY_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode (using IODELAY2)	-0.40/ 0.48	-0.40/ 0.53	-0.40/ 0.71	-0.71/ 0.86	ns
<b>Sequential Delays</b>						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	1.30	1.44	2.02	2.22	ns
F <sub>CLKDIV</sub>	CLKDIV maximum frequency	270	262.5	250	125	MHz

## Output Serializer/Deserializer Switching Characteristics

Table 38: OSERDES2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>OSDCK_D</sub> / T <sub>OSCKD_D</sub>	D input Setup/Hold with respect to CLKDIV	-0.03/ 1.02	-0.03/ 1.17	-0.03/ 1.27	-0.02/ 0.23	ns
T <sub>OSDCK_T</sub> / T <sub>OSCKD_T</sub> <sup>(1)</sup>	T input Setup/Hold with respect to CLK	-0.05/ 1.03	-0.05/ 1.13	-0.05/ 1.23	-0.05/ 0.24	ns
T <sub>OSCCK_OCE</sub> / T <sub>OSCKC_OCE</sub>	OCE input Setup/Hold with respect to CLK	0.12/ -0.03	0.15/ -0.03	0.24/ -0.03	0.28/ -0.17	ns
T <sub>OSCCK_TCE</sub> / T <sub>OSCKC_TCE</sub>	TCE input Setup/Hold with respect to CLK	0.14/ -0.08	0.17/ -0.08	0.27/ -0.08	0.31/ -0.16	ns
<b>Sequential Delays</b>						
T <sub>OSCKO_OQ</sub>	Clock to out from CLK to OQ	0.94	1.11	1.51	1.89	ns
T <sub>OSCKO_TQ</sub>	Clock to out from CLK to TQ	0.94	1.11	1.51	1.91	ns
F <sub>CLKDIV</sub>	CLKDIV maximum frequency	270	262.5	250	125	MHz

**Notes:**

1. T<sub>OSDCK\_T2</sub> / T<sub>OSCKD\_T2</sub> (T input setup/hold with respect to CLKDIV) are reported as T<sub>OSDCK\_T</sub> / T<sub>OSCKD\_T</sub> in TRACE report.

Table 44: DSP48A1 Switching Characteristics (Cont'd)

Symbol	Description	Pre-adder	Multiplier	Post-adder	Speed Grade				Units
					-3	-3N	-2	-1L	
$T_{DSPDCK\_OPMODE\_PREG}$ / $T_{DSPCKD\_OPMODE\_PREG}$	OPMODE input to P register CLK	Yes	Yes	Yes	6.21/ -0.84	7.27/ -0.84	7.27/ -0.84	10.43/ -0.84	ns
		No	Yes	Yes	1.69/ -0.87	1.98/ -0.87	1.98/ -0.87	3.62/ -0.87	ns
		No	No	Yes	2.09/ -0.22	2.30/ -0.22	2.30/ -0.22	3.79/ -0.22	ns
<b>Clock to Out from Output Register Clock to Output Pin</b>									
$T_{DSPCKO\_P\_PREG}$	CLK (PREG) to P output	N/A	N/A	N/A	1.20	1.34	1.34	1.90	ns
<b>Clock to Out from Pipeline Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_MREG}$	CLK (MREG) to P output	N/A	N/A	Yes	3.38	3.95	3.95	5.83	ns
<b>Clock to Out from Input Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_A1REG}$	CLK (A1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.65	ns
$T_{DSPCKO\_P\_B1REG}$	CLK (B1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.63	ns
$T_{DSPCKO\_P\_CREG}$	CLK (CREG) to P output	N/A	N/A	Yes	3.12	3.64	3.64	5.24	ns
$T_{DSPCKO\_P\_DREG}$	CLK (DREG) to P output	Yes	Yes	Yes	6.77	7.92	7.92	12.53	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>									
$T_{DSPDO\_A\_P}$	A input to P output	N/A	No	Yes	2.85	3.33	3.33	4.73	ns
		N/A	Yes	No <sup>(2)</sup>	3.35	3.93	3.93	6.74	ns
		N/A	Yes	Yes	4.56	5.22	5.22	8.94	ns
$T_{DSPDO\_B\_P}$	B input to P output	Yes	No	No <sup>(2)</sup>	3.22	3.76	3.76	5.55	ns
		Yes	Yes	No <sup>(2)</sup>	6.01	6.54	6.54	9.76	ns
		Yes	Yes	Yes	6.27	7.34	7.34	11.96	ns
$T_{DSPDO\_C\_P}$	C input to P output	N/A	N/A	Yes	2.69	3.15	3.15	4.68	ns
$T_{DSPDO\_D\_P}$	D input to P output	Yes	Yes	Yes	6.31	7.38	7.38	11.81	ns
$T_{DSPDO\_OPMODE\_P}$	OPMODE input to P output	Yes	Yes	Yes	6.43	7.52	7.52	11.84	ns
		No	Yes	Yes	4.84	5.66	5.66	9.25	ns
		No	No	Yes	3.11	3.49	3.49	5.03	ns
<b>Maximum Frequency</b>									
$F_{MAX}$	All registers used	Yes	Yes	Yes	390	333	333	213	MHz

**Notes:**

1. A Yes signifies that the component is in the path. A No signifies that the component is being bypassed. N/A signifies not applicable because no path exists.
2. Implemented in the post-adder by adding to zero.

Table 47: Configuration Switching Characteristics<sup>(1)</sup> (Cont'd)

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>BPI Master Flash Mode Programming Switching<sup>(4)</sup></b>						
T <sub>BPICCO</sub> <sup>(5)</sup>	A[25:0], FCS_B, FOE_B, FWE_B, LDC outputs valid after CCLK falling edge	15	15	15	20	ns, Max
T <sub>BPIICCK</sub>	Master BPI CCLK (output) delay	10/100	10/100	10/100	10/130	μs, Min/Max
T <sub>BPIDCC</sub> /T <sub>BPICCD</sub>	Setup/Hold on D[15:0] data input pins	5.0/1.0	5.0/1.0	5.0/1.0	6.0/2.0	ns, Min
<b>SPI Master Flash Mode Programming Switching<sup>(6)</sup></b>						
T <sub>SPIDCC</sub> /T <sub>SPIDCCD</sub>	DIN, MISO0, MISO1, MISO2, MISO3, Setup/Hold before/after the rising CCLK edge	5.0/1.0	5.0/1.0	5.0/1.0	7.0/1.0	ns, Min
T <sub>SPIIICCK</sub>	Master SPI CCLK (output) delay	0.4/7.0	0.4/7.0	0.4/7.0	0.4/10.0	μs, Min/Max
T <sub>SPICCM</sub>	MOSI clock to out	13	13	13	19	ns, Max
T <sub>SPICCF</sub>	CSO_B clock to out	16	16	16	26	ns, Max
<b>CCLK Output (Master Modes)</b>						
T <sub>MCCKL</sub>	Master CCLK clock duty cycle Low	40/60				%, Min/Max
T <sub>MCCKH</sub>	Master CCLK clock duty cycle High	40/60				%, Min/Max
F <sub>MCC</sub>	Maximum frequency, serial mode (Master Serial/SPI) All devices	40	40	40	30	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T	40	40	40	25	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX100 and LX100T in x8 mode, LX150, and LX150T	40	40	40	20	MHz, Max
	Maximum frequency, parallel mode (Master SelectMAP/BPI) LX100 and LX100T in x16 mode	35	35	35	20	MHz, Max
F <sub>MCCKTOL</sub>	Frequency Tolerance, master mode	±50	±50	±50	±50	%
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	5	5	5	8	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	5	5	5	8	ns, Min
<b>USERCCLK Input</b>						
T <sub>USERCCLKL</sub>	USERCCLK clock minimum Low time	12	12	12	16	ns, Min
T <sub>USERCCLKH</sub>	USERCCLK clock minimum High time	12	12	12	16	ns, Min
F <sub>USERCCLK</sub>	Maximum USERCCLK frequency	40	40	40	30	MHz, Max

**Notes:**

1. Maximum frequency and setup/hold timing parameters are for 3.3V and 2.5V configuration voltages.
2. To support longer delays in configuration, use the design solutions described in [UG380: Spartan-6 FPGA Configuration User Guide](#).
3. [Table 6](#) specifies the power supply ramp time.
4. BPI mode is not supported in:
  - LX4, LX25, or LX25T devices
  - LX9 devices in the TQG144 package
  - LX9 or LX16 devices in the CPG196 package.
5. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.
6. Defense-grade Spartan-6Q -2Q devices configure in single default SPI Master (x1) mode at  $T_j = -55^{\circ}\text{C}$ . During operation and when using all other configuration functions, the minimum operating temperature is  $-40^{\circ}\text{C}$ .

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM\_CLKGEN)<sup>(1)</sup>

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Output Frequency Ranges (DCM_CLKGEN)</b>											
CLKOUT_FREQ_FX	Frequency for the CLKFX and CLKFX180 outputs	5	375	5	375	5	333	5	200	MHz	
CLKOUT_FREQ_FXDV	Frequency for the CLKFXDV output	0.15625	187.5	0.15625	187.5	0.15625	166.5	0.15625	100	MHz	
<b>Output Clock Jitter<sup>(2)(3)</sup></b>											
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and CLKFX180 outputs.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKOUT_PER_JITT_FXDV	Period jitter at the CLKFXDV output.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKFX_FREEZE_VAR	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX > 50 MHz	Maximum = ±3% of CLKFX period								ps	
	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX < 50 MHz	Maximum = ±5% of CLKFX period								ps	
CLKFX_FREEZE_TEMP_SLOPE	CLKFX period will change in free oscillator mode over temperature. Add to CLKFX_FREEZE_VAR to determine total CLKFX period change. Percentage change for CLKFX period over 1°C.	Maximum = 0.1								%/°C	
<b>Duty Cycle<sup>(4)(5)</sup></b>											
CLKOUT_DUTY_CYCLE_FX	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
CLKOUT_DUTY_CYCLE_FXDV	Duty cycle precision for the CLKFXDV outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
<b>Lock Time</b>											
LOCK_FX <sup>(2)</sup>	The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX, CLKFX180, and CLKFXDV signals are valid. Lock time requires CLKFX_DIVIDE < F <sub>IN</sub> /(0.50 MHz) when: F <sub>CLKIN</sub> < 50 MHz	–	50	–	50	–	50	–	50	ms	
	when: F <sub>CLKIN</sub> > 50 MHz	–	5	–	5	–	5	–	5	ms	

Table 66: Global Clock Input to Output Delay With PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> PLL in System-Synchronous Mode.							
T <sub>C</sub> KOPLL	Global Clock and OUTFF <i>with</i> PLL	XC6SLX4	4.57	N/A	6.25	7.34	ns
		XC6SLX9	4.57	5.25	6.25	7.34	ns
		XC6SLX16	4.41	4.64	5.39	6.92	ns
		XC6SLX25	4.03	4.32	4.91	7.64	ns
		XC6SLX25T	4.03	4.32	4.91	N/A	ns
		XC6SLX45	4.63	4.96	5.75	7.36	ns
		XC6SLX45T	4.63	4.96	5.75	N/A	ns
		XC6SLX75	4.01	4.30	4.88	7.15	ns
		XC6SLX75T	4.01	4.30	4.88	N/A	ns
		XC6SLX100	4.02	4.33	4.90	7.37	ns
		XC6SLX100T	4.06	4.33	4.90	N/A	ns
		XC6SLX150	3.65	3.98	4.58	6.94	ns
		XC6SLX150T	3.65	3.98	4.58	N/A	ns
		XA6SLX4	4.88	N/A	6.13	N/A	ns
		XA6SLX9	4.88	N/A	6.13	N/A	ns
		XA6SLX16	4.74	N/A	5.27	N/A	ns
		XA6SLX25	4.43	N/A	4.78	N/A	ns
		XA6SLX25T	4.43	N/A	4.88	N/A	ns
		XA6SLX45	4.94	N/A	5.62	N/A	ns
		XA6SLX45T	4.94	N/A	5.62	N/A	ns
		XA6SLX75	4.32	N/A	4.77	N/A	ns
		XA6SLX75T	4.32	N/A	4.77	N/A	ns
		XA6SLX100	N/A	N/A	5.41	N/A	ns
		XQ6SLX75	N/A	N/A	4.77	7.15	ns
		XQ6SLX75T	4.32	N/A	4.77	N/A	ns
		XQ6SLX150	N/A	N/A	4.60	6.94	ns
		XQ6SLX150T	4.35	N/A	4.60	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is included in the timing calculation.

Table 71: Global Clock Setup and Hold Without DCM or PLL (Default Delay)

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Default Delay <sup>(2)</sup> Global Clock and IFF <sup>(3)</sup> without DCM or PLL	XC6SLX4	0.66/1.17	N/A	1.05/0.79	2.09/1.05	ns
		XC6SLX9	0.66/1.17	0.75/1.17	1.05/1.17	2.09/1.05	ns
		XC6SLX16	0.87/1.16	0.93/1.16	0.96/1.16	1.86/1.06	ns
		XC6SLX25	0.68/0.77	0.81/0.81	0.87/0.82	2.21/1.33	ns
		XC6SLX25T	0.68/0.77	0.81/0.81	0.87/0.82	N/A	ns
		XC6SLX45	0.40/1.05	0.42/1.17	0.64/1.20	1.61/1.67	ns
		XC6SLX45T	0.40/1.05	0.42/1.17	0.64/1.20	N/A	ns
		XC6SLX75	0.41/1.11	0.41/1.13	0.80/1.14	1.23/1.82	ns
		XC6SLX75T	0.41/1.11	0.41/1.13	0.80/1.14	N/A	ns
		XC6SLX100	0.39/1.12	0.39/1.23	0.39/1.28	1.13/1.94	ns
		XC6SLX100T	0.39/1.12	0.39/1.23	0.39/1.28	N/A	ns
		XC6SLX150	0.23/1.54	0.23/1.62	0.23/1.62	1.14/2.05	ns
		XC6SLX150T	0.23/1.54	0.23/1.62	0.23/1.62	N/A	ns
		XA6SLX4	0.73/1.18	N/A	1.05/0.80	N/A	ns
		XA6SLX9	0.73/1.18	N/A	1.05/0.80	N/A	ns
		XA6SLX16	0.90/1.20	N/A	0.96/0.75	N/A	ns
		XA6SLX25	0.70/0.81	N/A	0.87/0.91	N/A	ns
		XA6SLX25T	0.76/0.81	N/A	1.03/0.91	N/A	ns
		XA6SLX45	0.40/1.06	N/A	0.64/1.20	N/A	ns
		XA6SLX45T	0.40/1.06	N/A	0.64/1.20	N/A	ns
		XA6SLX75	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XA6SLX75T	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XA6SLX100	N/A	N/A	0.86/1.55	N/A	ns
		XQ6SLX75	N/A	N/A	0.80/1.18	1.23/1.82	ns
		XQ6SLX75T	0.41/1.24	N/A	0.80/1.18	N/A	ns
		XQ6SLX150	N/A	N/A	0.28/1.57	1.14/2.05	ns
		XQ6SLX150T	0.28/1.78	N/A	0.28/1.57	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. Default delay uses IODELAY2 tap 0.
3. IFF = Input Flip-Flop or Latch.

Table 74: Global Clock Setup and Hold With PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSPLL</sub> / T <sub>PHPLL</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in System-Synchronous Mode	XC6SLX4	1.37/0.25	N/A	1.52/0.41	2.07/0.69	ns
		XC6SLX9	1.37/0.21	1.48/0.21	1.52/0.26	2.07/0.69	ns
		XC6SLX16	1.33/-0.03	1.53/-0.02	1.60/-0.02	1.57/0.48	ns
		XC6SLX25	1.65/0.28	1.71/0.28	1.91/0.28	2.44/0.76	ns
		XC6SLX25T	1.65/0.28	1.71/0.28	1.91/0.28	N/A	ns
		XC6SLX45	1.55/0.18	1.64/0.18	1.75/0.18	2.02/0.90	ns
		XC6SLX45T	1.55/0.18	1.64/0.18	1.75/0.18	N/A	ns
		XC6SLX75	1.77/0.21	1.89/0.21	2.13/0.21	2.46/0.53	ns
		XC6SLX75T	1.77/0.21	1.89/0.21	2.13/0.21	N/A	ns
		XC6SLX100	1.44/0.32	1.52/0.32	1.70/0.32	1.78/0.86	ns
		XC6SLX100T	1.44/0.32	1.52/0.32	1.70/0.32	N/A	ns
		XC6SLX150	1.39/0.49	1.48/0.49	1.67/0.49	1.94/0.94	ns
		XC6SLX150T	1.39/0.49	1.48/0.49	1.67/0.49	N/A	ns
		XA6SLX4	1.61/0.10	N/A	1.64/0.28	N/A	ns
		XA6SLX9	1.61/0.10	N/A	1.64/0.28	N/A	ns
		XA6SLX16	1.89/-0.08	N/A	1.72/-0.08	N/A	ns
		XA6SLX25	1.85/0.16	N/A	2.08/0.16	N/A	ns
		XA6SLX25T	1.85/0.16	N/A	2.17/0.16	N/A	ns
		XA6SLX45	1.58/0.07	N/A	1.87/0.03	N/A	ns
		XA6SLX45T	1.58/0.07	N/A	1.87/0.03	N/A	ns
		XA6SLX75	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XA6SLX75T	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XA6SLX100	N/A	N/A	2.34/0.14	N/A	ns
		XQ6SLX75	N/A	N/A	2.25/0.06	2.46/0.53	ns
		XQ6SLX75T	1.80/0.06	N/A	2.25/0.06	N/A	ns
		XQ6SLX150	N/A	N/A	1.79/0.37	1.94/0.94	ns
		XQ6SLX150T	1.43/0.37	N/A	1.79/0.37	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 78: Duty Cycle Distortion and Clock-Tree Skew (Cont'd)

Symbol	Description	Device <sup>(1)</sup>	Speed Grade				Units
			-3	-3N	-2	-1L	
$T_{BUFIOSKEW}$	I/O clock tree skew across one clock region	LX4	0.06	N/A	0.06	0.07	ns
		LX9	0.06	0.06	0.06	0.07	ns
		LX16	0.06	0.06	0.06	0.07	ns
		LX25	0.06	0.06	0.06	0.07	ns
		LX25T	0.06	0.06	0.06	N/A	ns
		LX45	0.06	0.06	0.06	0.07	ns
		LX45T	0.06	0.06	0.06	N/A	ns
		LX75	0.06	0.06	0.06	0.07	ns
		LX75T	0.06	0.06	0.06	N/A	ns
		LX100	0.06	0.06	0.06	0.07	ns
		LX100T	0.06	0.06	0.06	N/A	ns
		LX150	0.06	0.06	0.06	0.07	ns
		LX150T	0.06	0.06	0.06	N/A	ns

**Notes:**

1. LXT devices are not available with a -1L speed grade. The LX4 is not available in -3N speed grade.
2. These parameters represent the worst-case duty cycle distortion observable at the pins of the device using LVDS output buffers. For cases where other I/O standards are used, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
3. The  $T_{CKSKEW}$  value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA Editor and Timing Analyzer tools to evaluate clock skew specific to your application.
4. The  $T_{CKSKEW}$  is 0.43 ns for the XA6SLX100 device using a -2 speed grade and 0.22 ns for the XC6SLX100 devices using the -2 speed grade.

Table 79: Package Skew

Symbol	Description	Device	Package <sup>(2)</sup>	Value	Units
$T_{PKGSKEW}$	Package Skew <sup>(1)</sup>	LX4	TQG144	N/A	ps
			CPG196	23	ps
			CSG225	58	ps
		LX9	TQG144	N/A	ps
			CPG196	23	ps
			CSG225	58	ps
			FT(G)256	88	ps
			CSG324	64	ps
		LX16	CPG196	19	ps
			CSG225	70	ps
			FT(G)256	71	ps
			CSG324	54	ps
		LX25	FT(G)256	90	ps
			CSG324	61	ps
			FG(G)484	84	ps
		LX25T	CSG324	48	ps
			FG(G)484	112	ps

Date	Version	Description of Revisions
01/10/11	1.11	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.4 software with speed specification v1.15 for the -4, -3, -3N, and -2 speed grades. Added note 3 to <a href="#">Table 27</a>. Also updated the -1L speed grade requirements to ISE v12.4 software with speed specification v1.06. Revised -3N definition throughout the document.</p> <p>Added note 4 to <a href="#">Table 2</a> and updated note 5. Added information on <math>V_{CCINT}</math> to note 1 in <a href="#">Table 5</a>. Updated Networking Applications -3 values in <a href="#">Table 25</a> to match improvements made in ISE v12.4. In <a href="#">Table 28</a>, added note 1 and revised the <math>T_{IOTP}</math> values for LVDS_33, LVDS_25, MINI_LVDS_33, MINI_LVDS_25, RSDS_33, RSDS_25, TMDS_33, PPDS_33, and PPDS_25. Added note 3 to <a href="#">Table 55</a>.</p>
02/11/11	1.12	<p>As described in <a href="#">XCN11008: Product Discontinuation Notice For Spartan-6 LXT -4 Devices</a>, the -4 speed specifications have been discontinued. As outlined in page 2 of the XCN, designers currently using -4 speed specifications should rerun timing analysis using the new -3 speed specifications before moving to a replacement device.</p> <p>Updated the networking applications section of <a href="#">Table 25</a>. Updated -2 speed specifications throughout document and added note 3 to <a href="#">Table 27</a> advising designers to use the -2 speed specification update (v1.17) with the ISE 12.4 software patch. Added <math>F_{CLKDIV}</math> to <a href="#">Table 37</a> and <a href="#">Table 38</a>. Updated note 2 in <a href="#">Table 39</a>. Updated units for <math>T_{SMCKCSO}</math> and <math>T_{BPICCO}</math> in <a href="#">Table 47</a>. Updated -1L in <a href="#">Table 71</a>. Removed Note 2: <i>Package delay information is available for these device/package combinations. This information can be used to deskew the package from Table 79.</i></p>
03/31/11	2.0	<p>Production release of XC6SLX45 in the -1L speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06.</p> <p>In <a href="#">Table 39</a>, removed values in the -1L column and added note 3 as IODELAY2 only supports Tap0 for lower-power devices. Updated copyright <a href="#">page 1</a> and <a href="#">Notice of Disclaimer</a>.</p>
05/20/11	2.1	<p>Production release of XC6SLX100 and XC6SLX150 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06. Updated <a href="#">Table 27</a> and <a href="#">Note 7</a> with changes per <a href="#">XCN11012: Speed File Change for -3N Devices</a>. Revised <a href="#">Switching Characteristics</a> section for speed specifications: v1.18 for -3, -3N, and -2; including improvements in <a href="#">Table 73</a> through <a href="#">Table 77</a> and <a href="#">Table 81</a>.</p> <p>Removed <i>Memory Controller Block</i> from the performance heading in <a href="#">Table 2</a> and revised <a href="#">Note 2</a>. In <a href="#">Table 4</a>, added <a href="#">Note 1</a> to <math>C_{IN}</math> and updated the description of <math>R_{IN\_TERM}</math>. Updated <a href="#">Note 1</a> in <a href="#">Table 5</a>. Updated <a href="#">Note 1</a> of <a href="#">Table 7</a>. In <a href="#">Table 25</a>, added and removed -1L specifications, increased the standard performance DDR3 specifications, removed the extended performance DDR3 row and updated <a href="#">Note 3</a> and <a href="#">Note 4</a>. Clarified the introductory information for <a href="#">Table 28</a> and <a href="#">Table 30</a>.</p> <p>In <a href="#">Table 32</a>: Revised <math>V_{MEAS}</math> value for LVCMOS12; revised <math>V_{REF}</math> for LVDS_25, LVDS_33, BLVDS_25, MINI_LVDS_25, MINI_LVDS_33, RSDS_25, and RSDS_33; revised <math>R_{REF}</math> for BLVDS_25 and TMDS_33; and added <a href="#">Note 4</a> and <a href="#">Note 5</a>. Updated <a href="#">Note 2</a> and <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p> <p>In <a href="#">Table 47</a>, revised the values and description of <math>T_{POR}</math> including adding <a href="#">Note 3</a>. Also in <a href="#">Table 47</a>, augmented the description and added specifications for <math>F_{RBCK}</math> and removed XC6SLX4 from <math>F_{MCCK}</math> (maximum frequency, parallel mode (Master SelectMAP/BPI)). Added BUFGMUX to <a href="#">Table 48</a> title. Added <a href="#">Table 50</a>.</p> <p>In <a href="#">Table 52</a>, revised specifications for <math>T_{EXTFDVAR}</math> and <math>F_{INJITTER}</math>. In <a href="#">Table 54</a> removed the 5 MHz &lt; <math>CLKIN\_FREQ\_DLL</math> parameter in the <math>LOCK\_DLL</math> description. In both <a href="#">Table 56</a> and <a href="#">Table 57</a>, removed the 5 MHz &lt; <math>F_{CLKIN}</math> parameter in the <math>LOCK\_FX</math> description. In <a href="#">Table 58</a>, updated description for <math>PSCLK\_FREQ</math> and <math>PSCLK\_PULSE</math>.</p> <p>Revised title and symbol of <a href="#">Table 70</a>, added new speed specifications for -1L, and added <a href="#">Note 2</a>. Added <a href="#">Table 71</a>.</p>
07/11/11	2.2	<p>Added the Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices to all appropriate tables while sometimes removing the XC6S nomenclature. Added expanded temperature range (Q) to all appropriate tables. Updated <math>T_{SOL}</math> packages in <a href="#">Table 1</a>. Added <math>R_{OUT\_TERM}</math> to <a href="#">Table 4</a>. Updated <a href="#">Note 2</a> on <a href="#">Table 13</a>.</p> <p>Production release of the XC6SLX4, XC6SLX9, XC6SLX16, XC6SLX25, XC6SLX75, XQ6SLX75, and XQ6SLX150 in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -1L speed specification v1.07.</p> <p>Production release of the XA6SLX16, XA6SLX25T, XA6SLX45, XA6SLX45T, XQ6SLX75, XQ6SLX75T, XQ6SLX150, and XQ6SLX150T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.</p> <p>Added <a href="#">Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices(1)</a>. Updated CS(G)484 from CSG484 throughout data sheet. Clarified <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p>
08/08/11	2.3	Production release of the XA6SLX25, XA6SLX75, and XA6SLX75T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.